Application/Control No. Applicant(s)/Patent Under Reexamination 10/658,472 MIYAIRI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Phillip Nguyen 2828 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 372/29.021 US-5,544,182 A 08-1996 Nagaishi et al. Α * US-5,128,601 A 07-1992 Orbach et al. 372/30 В * US-6,583,399 B1 06-2003 Hunziker et al. 250/214R С US-D US-

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